Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/511,270	NAKAJIMA ET AL.	
Examiner	Art Unit	
Rita Mitra	1656	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
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(INCLUDING SEARCH STRATEGY) DATE EXM				
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Updated: EAST: USPAT, US-PGPUB, EPO, JPO, DERWENT	3/31/2007	RM		
STN: BIOSIS, CAPLUS, MEDLINE, SCISEARCH				
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